AN11191 Application Note for the BGA7130 EVB 1930 - 1995 MHz Rev. 1.0 — 2 July 2012 Application Application

Application note

Document information

Info	Content
Keywords	Medium Power, 30 dBm, 1930 - 1995 MHz
Abstract	This Application Note describes the layout, schematics, characteristics and measurement methods of the BGA7130 tested in the 1930 - 1995 MHz range.



BGA7130 1930 - 1995 MHz EVB

Revision history

Rev	Date	Description
1.0	20120702	Initial document

Contact information

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1. Introduction

The BGA7130 is a wideband Silicon-Germanium MMIC (Monolithic Microwave Integrated Circuit) processed in NXPs mainstream Si QuBIC4+ BiCmos process. This process intrinsic inhibits high F_T figures (up to 28 GHz), while not compromising ruggedness (breakdown voltage) and noise figures. These characteristics make this device suitable for versatile RF e.g. final amplifier stages in E-Metering, MoCa (Multimedia on Coax), SMATV and ISM applications. The BGA7130 exhibits an integrated active bias circuit, to ensure almost flat performance over a temperature range from -40° C to $+85^{\circ}$ C. No additional bias circuitry is required to bias the device; the internal bias circuit ensures stable quiescent currents (450 mA) over temperature.

The BGA7130 is packaged in the SOT908-1, and in combination with the optimized die design, gives excellent thermal performance, which leads to lifetimes of the product that fulfills the demanding applications

To ensure optimal ESD protections, all pins are ESD protected.

All above mentioned highlight makes the BGA7130 an extremely attractive device with optimal performance/cost ratio, as compared to other devices in the market.

2. Product Profile

2.1 General description

The BGA7130 MMIC is a one-stage amplifier, offered in a low-cost leadless surface-mount package. It delivers 30 dBm output power at 5 V with high linearity. Its power saving features include simple quiescent current adjustment, which allows class-AB operation and logic-level shutdown control to reduce the supply current to 4 uA.

2.2 Features

- 400 MHz to 2700 MHz frequency operating range
- Integrated active biasing
- External matching allows broad application optimization of the electrical performance
- 3 V to 5 V single supply operation
- ESD protection at all pins
- Excellent ruggedness performance:
 - withstands open / short output mismatch conditions
 - withstands voltage peaks of 8.5 V supply voltage

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2.3 Applications

- Broadband CPE / MoCA
- WLAN / ISM / RFID
- Industrial applications
- Wireless infrastructure (base station, repeater, backhaul systems)
- Satellite Master Antenna TV (SMATV)

2.4 Application information

Table 1. Quick reference data

4.75 $V \le V_{SUP} \le 5.25 \ V$; -40 $^{\circ}C \le T_{case} \le +85 ^{\circ}C$; $p_i <$ -20 dBm; $R3 = 523 \ \Omega$ (tolerance 1 %); input and output impedances matched to 50 Ω ; pin ENABLE = HIGH; unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{SUP}	supply voltage		[1]	4.75	-	5.25	V
I _{CC(tot)}	total supply current		[2]	390	450	510	mA
		500 Ω ≤ R3 ≤ 4.7 kΩ	[2]	50	-	550	mA
		500 $\Omega \le R3 \le 4.7 \text{ k}\Omega$; pin ENABLE = LOW	[2]	-	4	6	μΑ
T _{case}	case temperature		[3]	-40	+25	+85	°C
f	frequency			400	-	2700	MHz
Measure	d at LTE-750 MHz						
f	frequency		[4]	728	748	768	MHz
Gp	power gain	728 MHz ≤ f ≤ 768 MHz		17	20	23	dB
P _{L(1dB)}	output power at 1 dB gain compression	728 MHz ≤ f ≤ 768 MHz		27	30.5	4	dBm
IP3 _O	output third-order intercept point	728 MHz ≤ f ≤ 768 MHz; P _L = 19 dBm per tone; tone spacing = 1 MHz		39	42.5	9.7	dBm
Measure	d at UMTS-2140 MHz						
f	frequency		[5]	211 0	214 0	2170	MHz
Gp	power gain	2110 MHz ≤ f ≤ 2170 MHz		9	12	15	dB
P _{L(1dB)}	output power at 1 dB gain compression	2110 MHz ≤ f ≤ 2170 MHz		27	30	e)	dBm
IP3 _O	output third-order intercept point	2110 MHz ≤ f ≤ 2170 MHz; P _L = 19 dBm per tone; tone spacing = 1 MHz		40.5	44	7	dBm

^[1] Supply voltage on pins RF_OUT and V_{CC} .

^[2] Current through pins RF_OUT and Vcc.

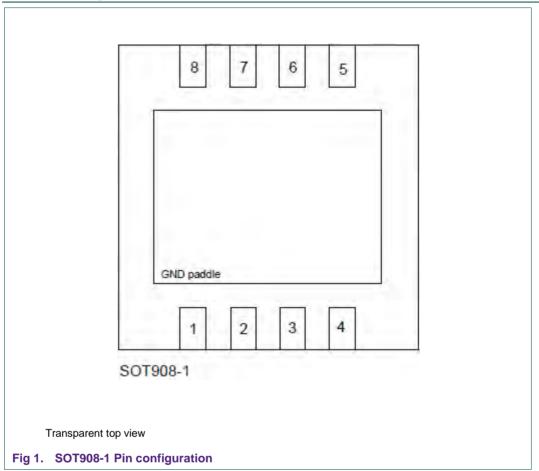
^[3] T_{case} is the temperature at the soldering point of the exposed die pad.

^[4] Covering downlink frequency range of eUTRAN bands 11, 13, 14 and 17.

^[5] Covering downlink frequency range of eUTRAN bands 1, 4 and 10.

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3. Pinning information

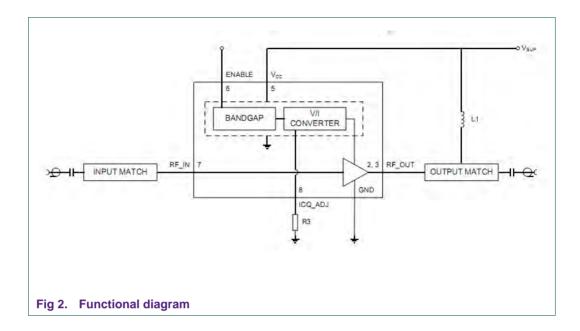


3.1 Pin description

Table 4.	Pin description	
Symbol	Pin	Description
n.c.	1, 4	not connected [1]
RF_OUT	2, 3	RF output and supply to the amplifier [2]
Vcc	5	bias supply voltage 3
ENABLE	6	enable
RF_IN	7	RF input [2]
ICQ_ADJ	8	quiescent collector current adjustment by an external resistor
GND	exposed die pad	ground [4]

- [1] This pin can be connected to ground.
- [2] This pin requires an external DC-blocking capacitor.
- [3] RF decoupled.
- [4] The exposed die pad of the SOT908-3 also functions as heatsink for the power amplifier.

4. Functional Diagram



As can be observed in Fig. 2, the bias and temperature control is fully integrated in the device, to accommodate ease of use in the application. The quiescent current can be adjusted by R2 (on the EVB R2 is a fixed resistor, but can be replaced by a trimmer potentiometer), while the RF can be switched on/off by a logic level ("0" or "1") on the shutdown pin (SHDN).

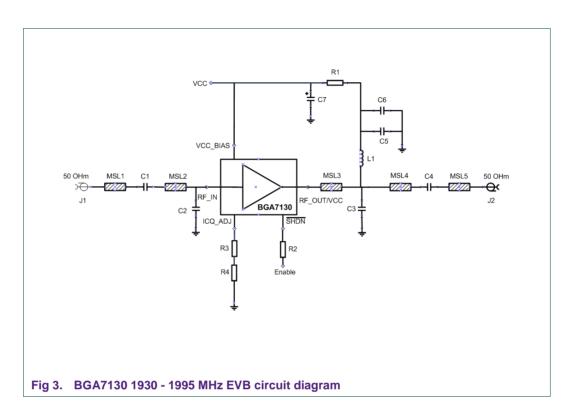
5. Evaluation Board (EVB)

The BGA7130 1930 - 1995 MHz EVB simplifies the evaluation of the BGA7130 RF MMIC, for the frequency band 1930 - 1995 MHz. The EVB enables testing of the device performance and requires no additional support circuitry. The board is assembled with BGA7130, including input- and output matching components, to optimize the performance. The board is utilized with SMA connectors at both input and output for connection to RF test equipment.

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5.1 Application circuit.

In Fig.3 the circuit diagram of the EVB is shown.



5.2 Bill of Materials (BOM)

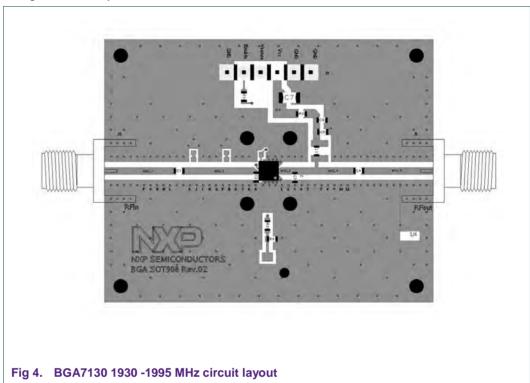
Component	Description	Value	Function	Remarks
J1,J2	RF connector	SMA		Emerson Network Power 142-0701-841
J3	DC connector	6 pins		
C7	capacitor	10 uF	DC decoupling	AVX 1206ZG106ZAT2A
C6	capacitor	1 uF	DC decoupling	Murata GRM188B31C105KA92
C5	capacitor	10 nF	DC decoupling	Murata GRM188B11E103KA01
C1,C4	capacitor	15 pF	DC blocking	Murata GRM1885C1H150JA01D
C2	capacitor	4.0 pF	input match	Murata GRM1885C1H4R0CZ01D
C3	capacitor	3.9 pF	output match	Murata GRM1885C1H3R9CZ01D
R1	resistor	270 Ω	ruggedness	
R2	resistor	0 Ω	-	
R3	resistor	523 Ω	bias setting	
R4	resistor	0 Ω	bias setting	Yageo RC0603JR-07220R
MSL1 [1]	micro stripline	W=1.14 mm, S=0.8 mm L=10.95 mm	50 Ohm line	
MSL2 [1]	micro stripline	W=1.14 mm, S=0.8 mm L=11.2 mm	input match	
MSL3 [1]	micro stripline	W=1.14 mm, S=0.8 mm L=2.7 mm	output match	
MSL4 [1]	micro stripline	W=1.14 mm, S=0.8 mm L=9.1 mm	output match	
MSL5 [1]	micro stripline	W=1.14 mm, S=0.8 mm L=10.95 mm	50 Ohm line	
L1	inductor	18 nH	DC Feed	Murata LQW18AN18NG10

[1] MSL1 to MSL6 dimensions specified as Width(W), Spacing (S) and Length (L)

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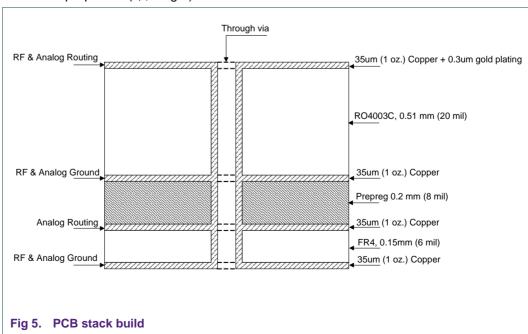
5.3 Board layout

In Figure 4, the layout of the BGA7130 circuit, as tuned for 1930 - 1995 MHz is shown.



5.4 PCB stack

The PCB is constructed as a four layer PCB (see Fig.5) stack. The width and the gap between the strip line and ground plane are configured such, that in combination with the RO4003C properties (ϵ_r , height) a 50 Ohm transmission line is defined.



5.5 Surface mount reflow soldering description

To ensure optimal performance- and lifetime of the device, proper soldering of the device on the PCB is a must. Proper soldering will ensure maximum heat transfer of the device to its environment (either free air or heat sink), hence minimizing the overall thermal resistance in order to keep the junction temperature low. A detailed description for surface mount reflow soldering can be found in the Application Note AN10365, on www.nxp.com.

6. Measurement conditions- and set-up's

In this section, the measurement conditions and measurement set-ups are described, as applied for the characterization data in this report.

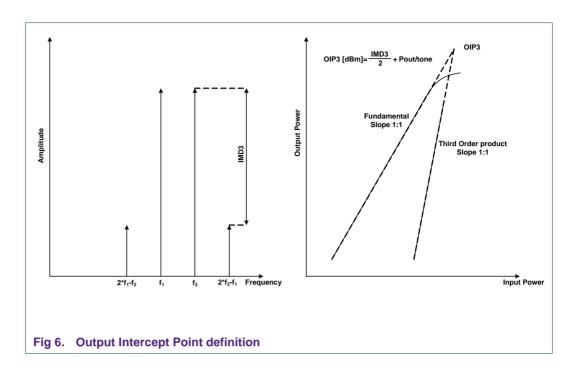
6.1 Output intercept point (OIP3) or IMD3

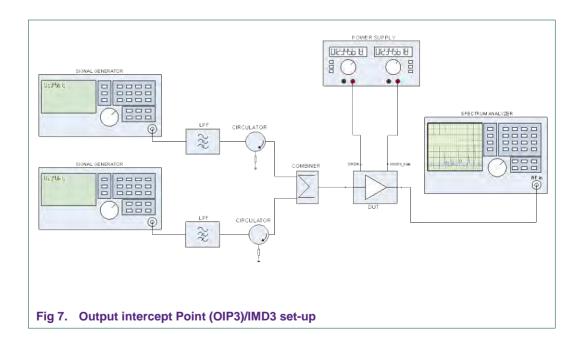
As a figure of merit for linearity, the output intercept point (OIP3) is defined (see Fig. 6). The measurement set-up (see Fig.7) is configured to achieve best performance. After the signal generators, a low pass filter (LPF) and isolator are applied, before combining the two signals. This configuration gives best isolation between the generators, hence a pure input spectrum of your signal. IMD3 levels of the input signal < -80 dBc can be achieved, so accurate IMD3 and OIP3 measurement are feasible.

6.1.1 OIP3/IMD3 measurement conditions

The OIP3 (or IMD3) of the EVB is measured with a tone spacing $\Delta f = (f_2 - f_1)$ of 1 MHz, and as function of the output power (either the average output power or output power per tone).

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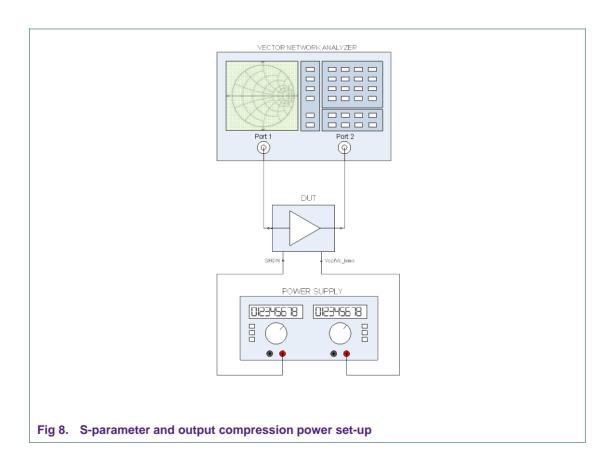
6.2 S-parameters and output compression point (P1dB).

Both S-parameters of the EVB and the output compression point are measured with a network analyzer (NWA). The P1dB is measured by sweeping the input power, and observe where the S21 of the device has compressed 1 dB compared to the linear gain (for this measurement a input power calibration with a power head has been performed, in order to accurate measure the input power). The output power of the device is calculated by Pout=Pin*gain(=S21)), see also Fig. 8. To enhance the drive power for the EVB optional a driver amplifier can be applied, in order to prevent that output signal of the EVB drives the receiver of the NWA into compression, and output attenuator can be an option (both driver amplifier and attenuator should be included in the calibration path).

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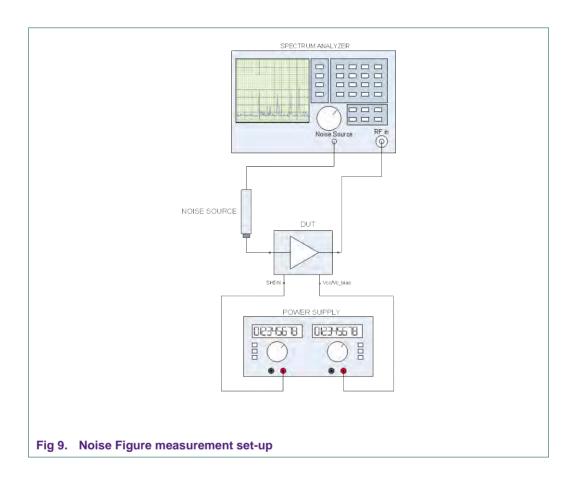
6.2.1 S-parameter measurement conditions

In order to maintain small signal conditions for the S-parameter measurements, an input power of -30 dBm is applied.



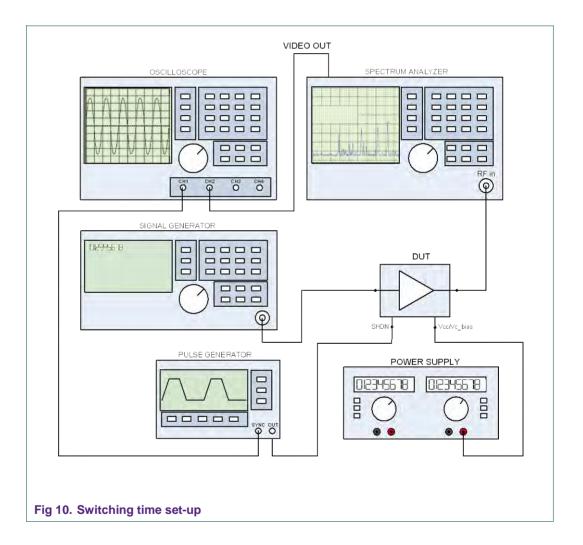
6.3 Noise Figure Measurements (NF).

The Noise Figure (NF) of the EVB is measured with a calibrated noise source (with a specified Excess Noise Ratio (ENR), and with a spectrum analyzer with noise measurement option. The system is calibrated with this noise source, in order to measure accurate noise figures (see Fig. 9).



6.4 Switching time measurements.

The switching times (the RF output of the BGA7130 can be switched on/off by enabling/disabling the devices via control of the SHDN pin) are measured according the set-up, as described in Fig. 10. The RF output is switched on/off by a pulse generator (which also supplies the trigger signal to the oscilloscope), while the RF response is measured with a spectrum analyzer, in the zero span mode. The envelope of the RF output signal is fed to the oscilloscope by means of the VIDEO OUT option of the spectrum analyzer.



7. User instructions

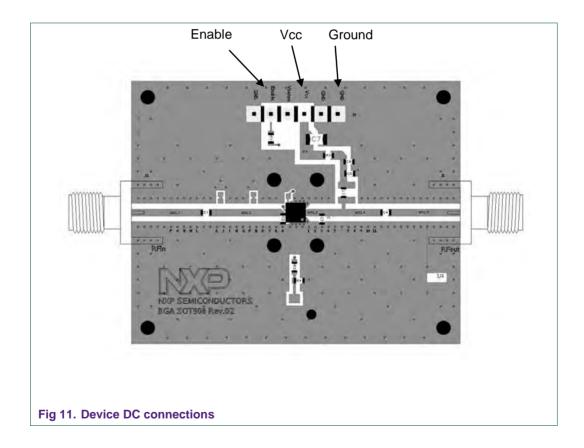
For proper operation of the EVB, the following instructions should be followed:

To power on the device, follow the sequence below:

- Connect the ground to one of the ground pins
- Connect 5V to the VCC pin
- Connect 5V to the enable pin

To power off the device, follow the sequence below:

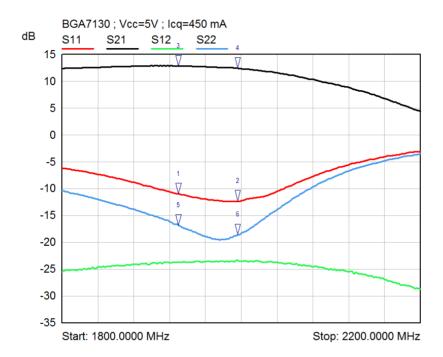
- Disconnect 5V to the enable pin
- Disconnect 5V to the VCC pin
- Disconnect the ground to one of the ground pins



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8. Typical measurement results

8.1 S-parameters: Vcc=5V; Icc=450mA



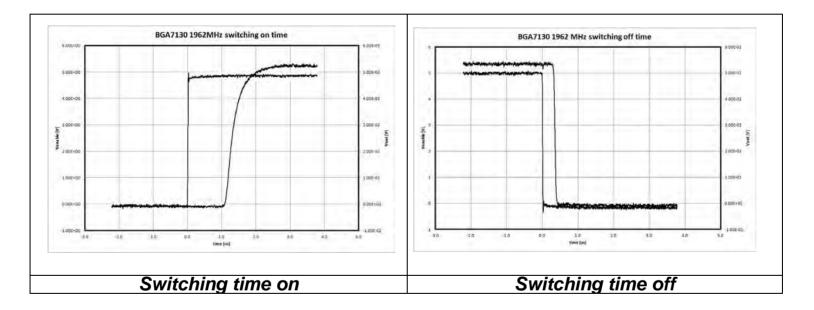
Mkr	Trace	X-Axis	Value	Notes
1 🎖	S11	1930.0000 MHz	-10.98 dB	
2 🏹	S11	1996.0000 MHz	-12.32 dB	
3 ▽	S21	1930.0000 MHz	12.86 dB	
4 ▽	S21	1996.0000 MHz	12.39 dB	
5 🎖	S22	1930.0000 MHz	-16.83 dB	
6 ▽	S22	1996.0000 MHz	-18.56 dB	

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8.2 P1dB and OIP3: Vcc=5V; Icc=450 mA; frequency = 1930 - 1995 MHz

freq [MHz]	P1dB [dBm]	OIP3 [dBm]
1930	30.3	42
1995	30.8	42.3

8.3 Switching times: Vcc=5V; Icc=450 mA; frequency = 1962 MHz



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